IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Divisional U.S. Patent Application of:

Glen FOX, et al.

Serial No.

Filed: July 15, 2003

Title: A CHARGE PUMP OR OTHER CHARGE STORAGE CAPACITOR INCLUDING PZT LAYER FOR COMBINED USE AS AN **ENCAPSULATE LAYER AND DIELECTRIC**

LAYER OF A FERROELECTRIC CAPACITOR AND A METHOD OF MANUFACTURING THE SAME

Examiner:

Art Unit:

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Alexandria, VA 22313-1450

Sir:

Pursuant to 37 C.F.R. § 1.97 the Examiner may wish to consider the references listed on the attached Form PTO/SB/08A. In submitting these references for the Examiner's consideration, no representation is made or implied that the references are or are not material to the examination of the application. The Examiner is encouraged to make his or her own determination of materiality.

Each of these references were either cited or provided in U.S. Patent Application Serial No. 09/862,365, and/or U.S. Patent Application Serial No. 09/862,365, from which priority under 35 U.S.C. § 120 is claimed. Pursuant to 37 C.F.R. § 1.98, copies of the references are not provided.

No fee is believed due. However, any fees associated with this communication may be charged to Deposit Account No. 50-1123.

Respectfully submitted,

July 15, 2003

Carol W. Burton, Reg. No. 35,465

HOGAN & HARTSON

One Tabor Center

1200 17th Street, Suite 1500

Denver, Colorado 80202

(303) 454-2457 Tel

(303) 899-7333 Fax

PTO/SB/08A (10/01) (Substitute for form 1449A/PTO)	ATTY. DOCKET NO. RAM 482 DIV2 Client/Matter No. 80412.0135.002 FIRST NAMED INVENTOR: Glen FOX		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT			
(Use several sheets if necessary)	FILING DATE: July 15, 2003	ART UNIT:	
Sheet1 of1			

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document No. No. – Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Doc	
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		5,266,821	11-30-1993	Chern et al.	
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		6,010,927	01-2000	Jones et al.	
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		0-449-484-A1	03-30-1990	EPO			,
		0 415 751 A1	06-03-1991	EPO			
		5-267557	01-19-1994	Japan			
		2-260559	01-08-1991	Japan			
		5-135999 A	01-06-1993	Japan			

OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS

No. journal, serial, symposium, catalog, etc.), da		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s) publisher, city and/or country where published
		Liu et al., "Low-Temperature Fabrication of Amorphous BaTiO3 Thin-Film Bypass Capacitors," IEEE Device Letters (1993) 14:320-322

EXAMINER SIGNATURE DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.